

FORM PTO-1449	U.S. Department of Commerce Patent and Trademark Office	Atty. Docket No. MNE00367D01	Serial No.
LIST OF REFERENCES CITED BY APPLICANT Page 1 of 2		Applicants William L. Reber et al.	
		Filing Date 8/21/00	Group

JC892 U.S. PTO
 09/642916
 08/21/00

U.S. PATENT DOCUMENTS							
Examiner's Initials		Document No.	Date	Name	Class	Subclass	Filing Date (If Appropriate)
JC	A A	4,175,269	11/20/79	Rebikoff	358	99	
JC	A B	5,045,939	09/03/91	Okayama et al.	358	140	
JC	A C	5,185,667	02/09/93	Zimmerman	358	209	
JC	A D	5,236,199	08/17/93	Thompson, Jr.	273	439	
JC	A E	5,367,329	11/22/94	Nakagaki et al.	348	1	
JC	A F	5,384,588	01/24/95	Martin et al.	348	15	
JC	A G	5,432,871	07/11/95	Novik	382	232	
JC	A H	5,488,411	01/30/96	Lewis	348	8	
JC	A I	5,594,935	1/1997	Reber et al.	455	2	
JC	A J	5,646,677	7/1997	Reber	348	13	
JC	A K	5,706,421	1/1998	Reber et al.	395	173	

FOREIGN PATENT DOCUMENTS							
		Document No.	Date	Country	Class	Subclass	Translation Yes No
JC	A L	5-0130528	05/25/93	Japan	H04N	5/44	
JC	A M	0064167	03/12/93	Japan	H04N	7/08	
JC	A N	0083471	4/91	Japan	H04N7	18	
JC	A O	0277089	11/89	Japan	H04N7	18	

OTHER (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)		
JC	AP	Peering Out a 'Real Time' Window" by Peter H. Lewis, The New York Times, Wednesday, February 8, 1995
	AR	
	AS	
	AT	

Examiner <i>Jason Chung</i>	Date Considered <i>7/22/04</i>
EXAMINER Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form for next communication to Applicant.	

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JC	AA	6,037,991	3/2000	Thro et al.	348	469	
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	AD						
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	AH						
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	AK						

FOREIGN PATENT DOCUMENTS

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							Yes	No
JC	AL	0121318	4/94	Japan	H04N7	18		
	AM							
	AN							
	AO							

OTHER (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

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